Power Field Effect Transistor DPAK for Surface Mount

N-Channel Enhancement-Mode Silicon Gate

This TMOS Power FET is designed for high speed, low loss power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds
- Low $R_{DS(on)}$ 0.3 Ω Max
- Rugged SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads
- Low Drive Requirement V_{GS(th)} = 4.0 V Max
- Surface Mount Package on 16 mm Tape

MAXIMUM RATINGS

Rating	Symbol	Value	Unit		
Drain-Source Voltage	V_{DSS}	150	Vdc		
Drain–Gate Voltage ($R_{GS} = 1.0 \text{ M}\Omega$)	V_{DGR}	150	Vdc		
Gate–Source Voltage — Continuous — Non–Repetitive $(t_p \le 50~\mu s)$	V_{GS} V_{GSM}	± 20 ± 40	Vdc Vpk		
Drain Current — Continuous — Pulsed	I _D I _{DM}	6.0 20	Adc		
Total Power Dissipation @ T _C = 25°C Derate above 25°C	P _D	20 0.16	Watts W/°C		
Total Power Dissipation @ T _A = 25°C Derate above 25°C (Note 1)	P_{D}	1.25 0.01	Watts W/°C		
Total Power Dissipation @ T _A = 25°C (1) Derate above 25°C (Note 2)	P _D	1.75 0.014	Watts W/°C		
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to +150	°C		

THERMAL CHARACTERISTICS

Characteristic	Symbol	Value	Unit
Thermal Resistance – Junction to Case – Junction to Ambient (Note 1) – Junction to Ambient (Note 2)	R _{θJC} R _{θJA} R _{θJA}	6.25 100 71.4	°C/W

- 1. When surface mounted to an FR4 board using the minimum recommended pad size.
- 2. When surface mounted to an FR4 board using 0.5 sq. in. drain pad size.

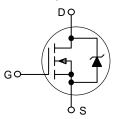


ON Semiconductor®

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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
150 V	0.3 Ω	6.0 A

N-CHANNEL





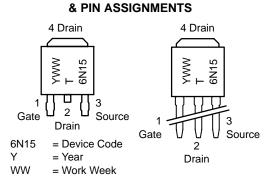


(Surface Mount)

CASE 369C CASE 369D **DPAK DPAK**

(Straight Lead)

STYLE 2 STYLE 2 **MARKING DIAGRAM**



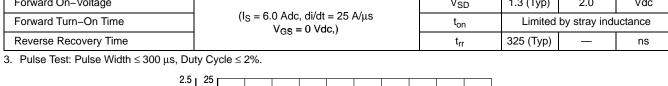
ORDERING INFORMATION

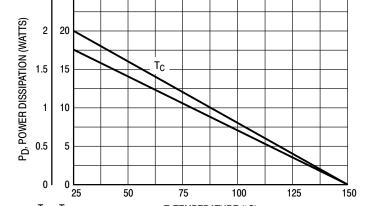
Device	Package	Shipping [†]		
MTD6N15	DPAK	75 Units/Rail		
MTD6N15-1	DPAK Straight Lead	75 Units/Rail		
MTD6N15T4	DPAK	2500 Tape & Reel		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

$\textbf{ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted)$

Cha	Symbol	Min	Max	Unit	
OFF CHARACTERISTICS		<u> </u>			
Drain-Source Breakdown Voltage (V _{GS} = 0 Vdc, I _D = 0.25 mAdc)	V _{(BR)DSS}	150	_	Vdc	
Zero Gate Voltage Drain Current (V_{DS} = Rated V_{DSS} , V_{GS} = 0 Vdc) T_J = 125°C	I _{DSS}	_	10 100	μAdc	
Gate-Body Leakage Current, Forward	d (V _{GSF} = 20 Vdc, V _{DS} = 0)	I _{GSSF}	_	100	nAdc
Gate-Body Leakage Current, Reverse	e (V _{GSR} = 20 Vdc, V _{DS} = 0)	I _{GSSR}	_	100	nAdc
ON CHARACTERISTICS (Note 3)					
Gate Threshold Voltage ($V_{DS} = V_{GS}$, I $T_J = 100^{\circ}C$	_D = 1.0 mAdc)	V _{GS(th)}	2.0 1.5	4.5 4.0	Vdc
Static Drain-Source On-Resistance (V _{GS} = 10 Vdc, I _D = 3.0 Adc)	R _{DS(on)}	_	0.3	Ohm
	V _{DS(on)}	_	1.8 1.5	Vdc	
Forward Transconductance (V _{DS} = 15	9FS	2.5	_	mhos	
DYNAMIC CHARACTERISTICS		<u> </u>			
Input Capacitance	(V _{DS} = 25 Vdc, V _{GS} = 0 Vdc,	C _{iss}	_	1200	pF
Output Capacitance	f = 1.0 MHz)	C _{oss}	_	500	
Reverse Transfer Capacitance	See Figure 11	C _{rss}	_	120	
SWITCHING CHARACTERISTICS* (T.	= 100°C)				
Turn-On Delay Time		t _{d(on)}	_	50	ns
Rise Time	$(V_{DD} = 25 \text{ Vdc}, I_D = 3.0 \text{ Adc},$	t _r	_	180	1
Turn-Off Delay Time	$R_G = 50 \Omega$) See Figures 13 and 14	t _{d(off)}	_	200	1
Fall Time		t _f	_	100	
Total Gate Charge	(V _{DS} = 0.8 Rated V _{DSS} ,	Qg	15 (Typ)	30	nC
Gate-Source Charge	I_D = Rated I_D , V_{GS} = 10 Vdc)	Q _{gs}	8.0 (Typ)	_	
Gate-Drain Charge	See Figure 12	Q _{gd}	7.0 (Typ)		
SOURCE-DRAIN DIODE CHARACTE	RISTICS*				
Forward On-Voltage		V _{SD}	1.3 (Typ)	2.0	Vdc
Forward Turn-On Time	$(I_S = 6.0 \text{ Adc}, \text{ di/dt} = 25 \text{ A/}\mu\text{s})$ $V_{GS} = 0 \text{ Vdc},)$	t _{on}	Limited	by stray ind	luctance
Reverse Recovery Time	1 *65 - 0 *40,/	tee	325 (Typ)	_	ns





T, TEMPERATURE (°C) Figure 1. Power Derating

100

125

150

75

50

 T_{A} T_{C}

TYPICAL ELECTRICAL CHARACTERISTICS

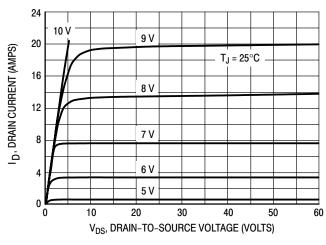


Figure 2. On-Region Characteristics

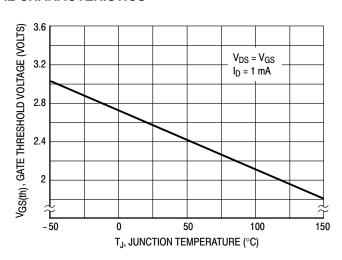


Figure 3. Gate-Threshold Voltage Variation With Temperature

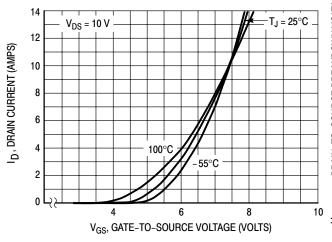


Figure 4. Transfer Characteristics

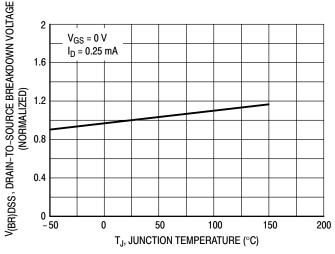


Figure 5. Breakdown Voltage Variation
With Temperature

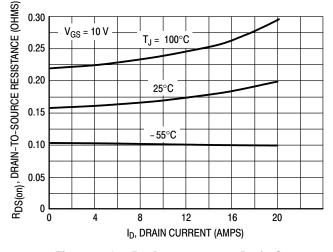


Figure 6. On-Resistance versus Drain Current

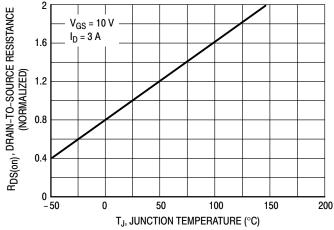


Figure 7. On–Resistance Variation
With Temperature

SAFE OPERATING AREA

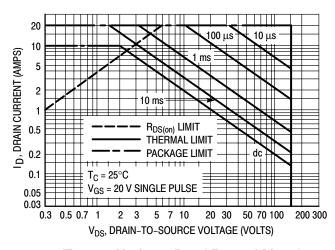


Figure 8. Maximum Rated Forward Biased Safe Operating Area

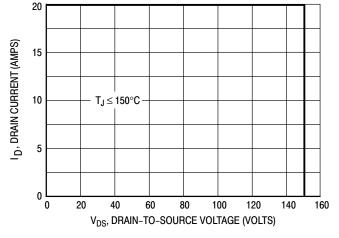


Figure 9. Maximum Rated Switching Safe Operating Area

FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 9 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current, I_{DM} and the breakdown voltage, $V_{(BR)DSS}$. The switching SOA shown in Figure 8 is applicable for both turn—on and turn—off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:

$$\frac{T_{J(max)} - T_C}{R_{\theta JC}}$$

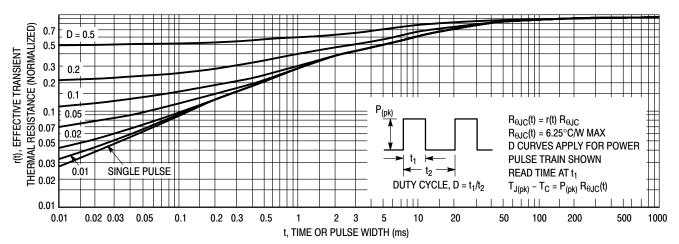
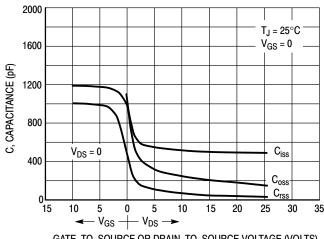


Figure 10. Thermal Response



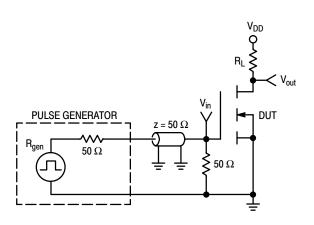
VGS, GATE SOURCE VOLTAGE (VOLTS) $T_J = 25^{\circ}C$ I_D = 6 A 12 75 V 120 V $V_{DS} = 50 \text{ V}$ 0 16 12 4 20 Q_g, TOTAL GATE CHARGE (nC)

GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 11. Capacitance Variation

Figure 12. Gate Charge versus Gate-To-Source Voltage

RESISTIVE SWITCHING



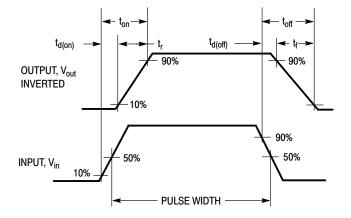
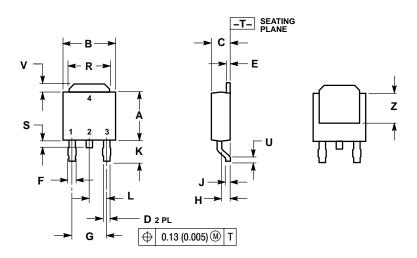


Figure 13. Switching Test Circuit

Figure 14. Switching Waveforms

PACKAGE DIMENSIONS

DPAK CASE 369C-01 ISSUE O

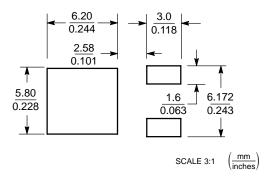


- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180	BSC	4.58	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

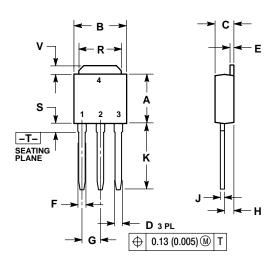
SOLDERING FOOTPRINT*

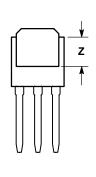


^{*}For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

DPAK CASE 369D-01 ISSUE O





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F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

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